PRELIMINARY

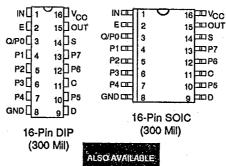
DS1020

Programmable 8-Bit Silicon Delay Line

FEATURES

- All-silicon time delay
- Models with 0.25ns, 0.5ns, 1ns, and 2ns steps
- Leading and trailing edge accuracy
- Standard 16-pin DIP or 16-pin SOIC
- Auto-insertable
- Low-power CMOS
- TTL/CMOS-compatible
- Programmable using 3-wire serial port or 8-bit parallel port

PIN DESCRIPTION



INDIEFORM

PIN NAMES

IN	-Delay Input
P0-P7	-Parallel Program Pin
GND	-Ground
OUT	-Delay Output
v _{cc} s	- +5 volts
s̃	-Mode Select
E	-Enable
С	-Serial Port Clock
Q	-Serial Data Output
D	-Serial Data Input

logic level is reproduced at the output without inversion. The DS1020 is TTL- and CMOScompatible, capable of driving 10 74LS-type loads, and features both rising and falling edge accuracy.

The all-CMOS DS1020 integrated circuit has been designed as a reliable, economic alternative to hybrid programmable delay lines. It is offered in a standard 16-pin auto-insertable DIP and a space-saving surface mount 16-pin SOIC.

DESCRIPTION

The DS1020 Programmable 8-Bit Silicon Delay Line product family consists of 8-bit, user-programmable CMOS silicon integrated circuits. Delay values, programmed using either the 3wire serial port or the 8-bit parallel port, can be varied over 256 equal steps. The fastest model (-025) offers a maximum delay of 73.75ns with an incremental delay of 0.25ns, while the slowest model (-200) has a maximum delay of 520ns with an incremental delay of 2ns. All models have an inherent (step zero) minimum delay of 10ns. After the user-determined delay, the input T-47-17

39E D

PARALLEL MODE (S = 1)

In the PARALLEL programming mode, the output of the DS1020 will reproduce the logic level of the input after a delay determined by the state of the eight program input pins P0 - P7. The parallel inputs can be programmed using DC levels or computer-generated data. To provide for infrequent modification of the delay value, jumpers should be used to connect the input pins to V_{cc} and ground. For applications requiring frequent timing adjustment, DIP switches can be used. The enable pin (E) must be at a logic 1 in hardwired implementations.

Maximum flexibility is obtained when the eight parallel programming bits are set using computer-generated data. By observing the data setup (T_{DSE}) and data hold (T_{DHE}) requirements, the enable pin can be used to latch data supplied on an 8-bit bus. Enable must be held at a logic 1 if it is not used to latch the data. After each change in delay value, a settling time (T_{EDV} or T_{PDV}) is required before input logic levels are accurately delayed.

Since the DS1020 is a CMOS design, unused Input pins (D and C) must be connected to welldefined logic levels; they must not be allowed to float.

SERIAL MODE (S = 0)

In the SERIAL programming mode, the output of the DS1020 will reproduce the logic level of the input after a delay time determined by an 8-bit value clocked into serial port D. While observing data setup (T_{psc}) and data hold (T_{pHc}) requirements, timing data is loaded in MSB-to-LSB order by the rising edge of the serial clock (C). The enable pin (E) must be at a logic 1 to load or read the internal 8-bit input register, during which time the delay is determined by the last value activated. Data transfer ends and the new delay value is activated when enable (E) returns to a logic 0. After each change, a settling time (T_{env}) is required before the delay is accurate.

As timing values are shifted into the serial data input (D), the previous contents of the 8-bit input register are shifted out of the serial output pin (Q) in MSB-to-LSB order. By connecting the serial output of one DS1020 to the serial input of a second DS1020, multiple devices can be daisy-chained (cascaded) for programming purposes (Figure 3). The total number of serial bits must be eight times the number of units daisy-chained and each group of 8 bits must be sent in MSB-to-LSB order.

Applications can read the setting of the DS1020 delay line by connecting the serial output pin (Q) to the serial input (D) through a resistor with a value of 1K to 10K ohms (Figure 2). Since the read process is destructive, the resistor restores the value read and provides isolation when writing to the device. The resistor must connect the serial output (Q) of the last device to the serial input (D) of the first device of a daisy-chain (Figure 3). For serial readout with automatic restoration through a resistor, the device used to write serial data must go to a high impedance

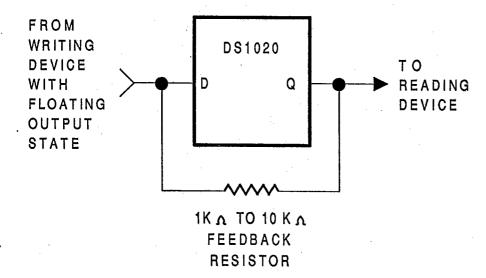
To initiate a serial read, enable (E) is taken to a logic 1 while serial clock (C) is at a logic 0. After a waiting time (T_{EQV}), bit 7 (MSB) appears on the serial output (Q). On the first rising (0 --> 1) transition of the serial clock (C), bit 7 (MSB) is rewritten and bit 6 appears on the output after a time T_{cov}. To restore the input register to its original state, this clocking process must be repeated 8 times. In the case of a daisy-chain, the process must be repeated 8 times per package. If the value read is restored before enable (E) is returned to logic 0, no settling time (T_{EDV}) is required and the programmed delay remains unchanged.

Since the DS1020 is a CMOS design, unused input pins (P1 - P7) must be connected to welldefined logic levels; they must not be allowed to float. Serial output Q/P0 should be allowed to float if unused.

FUNCTIONAL BLOCK DIAGRAM Figure 1 T-47-17 PROGRAMMABLE DELAY ENABLE LATCH MODE SELECT (S) 8-BIT INPUT SERIAL OUTPUT (Q) CLOCK (C) REGISTER SERIAL INPUT (D) P0 P1 P2 P3 P4 P5 P6 P7

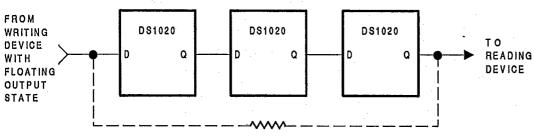
(MSB)

SERIAL READOUT Figure 2



(LSB)

CASCADING MULTIPLE DEVICES (DAISY CHAIN) Figure 3



1KA TO 10 KA OPTIONAL FEEDBACK RESISTOR

PART NUMBER TABLE Table 1

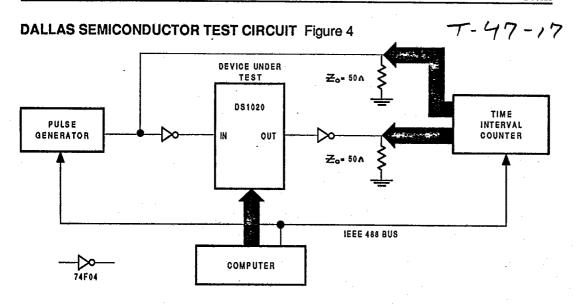
DELAYS AND TOLERANCES (in ns)						
PART NUMBER STEP ZERO MAX DELAY DELAY CHANGE MAX DEVIATION DELAY TIME (NOM) PER STEP (NOM) FROM PROGRAMED DELAY						
DS1020-025	10 ± 2	73.75	0.25	± 4		
DS1020-050	10 ± 2	137.5	0.5	± 6		
DS1020-100	10±2	265	1	± 8		
DS1020-200	10±3	520	2	± 12		

DELAY VS. PROGRAMMED VALUE Table 2

	STEP ZERO						
BINARY	0	0	0	0	0	0	_
PROGRAM-	0	0	0	0	0	0	_
MED VALUE	0	0	0	0	0	0	_
·	0	0	0	0	0	0	_
	0	0	0	0	0	0	_
	0	0	0	0	1	1	_
PART	0	0	1	1	0	0	_
NUMBER	0	1	0	1	0	1	_
DS1020-025	10.00	10.25	10.50	10.75	11.00	11.25	-
DS1020-050	10.0	10.5	11.0	11.5	12.0	12.5	_
DS1020-100	10	11	12	13	14	15	_
DS1020-200	10	12	14	16	18	20	

				PAR-	
					SERIAL
_			DELAY		PORT
	1	1	1	P7	MSB
	1	1	1	P6	
	1	1	1	P5	
	1	1	1	P4	
	1	1	1	РЗ	
	1	1	1	P2	
	0	1	1	P1	
	1	0	1	P0	LSB
Ξ	73.25	73.50	73.75		
	136.5	137.0	137.5		
	263	264	265		
	516	518	520		

All delays in nanoseconds, referenced to input pin.



TEST SETUP DESCRIPTION

Figure 4 illustrates the hardware configuration used for measuring the timing parameters of the DS1020. The input waveform is produced by a precision pulse generator under software control. Time delays are measured by a time interval counter (20 ps resolution) connected to

the output. The DS1020 serial and parallel ports are controlled by interfaces to a central computer. All measurements are fully automated with each instrument controlled by the computer over an IEEE 488 bus.

INPUT:

Ambient Temperature: Supply Voltage (Vcc): Input Pulse:

Source Impedance: Rise and Fall Time:

Pulse Width:

Period:

25°C ± 3°C

 $5.0V \pm 0.1V$

 $High = 3.0V \pm 0.1V$

TEST CONDITIONS

Low = $0.0V \pm 0.1V$

50 Ohms Max.

3.0 ns Max.

(measured between 0.6V and 2.4V)

500 ns (DS1020-025, -050, -100)

1000 ns (DS1020-200)

1 us (DS1020-025, -050, -100)

2 us (DS1020-200)

NOTE:

Above conditions are for test only and do not restrict the operation of the device under other data sheet conditions.

OUTPUT:

Output is loaded with a 74F04. Delay is measured between the 1.5V level of the rising edge of the input signal and the 1.5V level of the corresponding edge of the output.

DS1020

ABSOLUTE MAXIMUM RATINGS*

Voltage on any Pin Relative to Ground:

Operating Temperature:

Storage Temperature: Soldering Temperature:

Short Circuit Output Current:

-1.0V to +7.0V

-40°C to +85°C

-55°C to +125°C

250°C for 10 Sec.

50 mA for 1 Sec.

*This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

DC ELECTRICAL CHARACTERISTICS

 $(0^{\circ}\text{C to }70^{\circ}\text{C}, V_{\text{CC}} = 5.0\text{V} \pm 5\%)$

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O LLLOTHIOAL OHAHAOT LINOTIO			,	(0 0 to 70 0, V _{CC} = 3.0V ± 3/6)			
PARAMETER	SYM	TEST COND.	MIN	TYP	MAX	UNITS	NOTES
Supply Voltage	V _∞	-	4.75	5.00	5.25	V	1
High Level Input Voltage	V _H		2.2		V _{CC} + 0.5	V	1
Low Level Input Voltage	V _L		-0.5	·	0.8	٧	. 1
Input Leakage Current	l _i .	0≤ V _I ≤ V _{CC}	-1.0		1.0	uA	
Active Current	l _{cc}	V _{cc} = Max. Period = 1us			30.0	mA	
High Level Output Current	l _{oн}	V _{CC} = Min. V _{OH} = 2.7V			-1.0	mA	
Low Level Output Current	la	V _{CC} = Min. V _{OL} = 0.5V	12.0			mA	

T-47-17

DS1020

(0°C to 70°C, $V_{CC} = 5V \pm 5\%$)

MAX UNITS NOTES **AC ELECTRICAL CHARACTERISTICS** SYMBOL TYP PARAMETER MIN **Clock Frequency** 10 fc MHz **Enable Width** 50 tew ns Clock Width 50 tow ns Data Setup to Clock 30 tosc ns Data Hold from Clock t_{DHC} 10 ns Data Setup to Enable 30 tose ns Data Hold from Enable 10 ns t_{DHE} **Enable to Serial** Output Valid 50 t_{EQV} ns **Enable to Serial** Output High Z 0 50 ns t_{EQZ} Clock to Serial **Output Valid** 50 tcov ns Clock to Serial Output Invalid 10 tcax ns **Enable Setup to Clock** 50 tes ns **Enable Hold from Clock** t_{en} 50 ns Parallel Input Valid to Delay Valid 50 us t_{PDV} Parallel Input Change to Delay Invalid t_{PDX} 0 ns Enable to Delay Valid 50 us t_{EDV} Enable to Delay Invalid 0 t_{EDX} ns V_{cc} Valid to Device Functional 100 t_{PŲ} us Input Pulse Width 100% of twi ns Output Delay Input to Output Delay Table 2 2 t_{PLH},t_{PHL} ns

3(t_{wi})

Period

Input Period

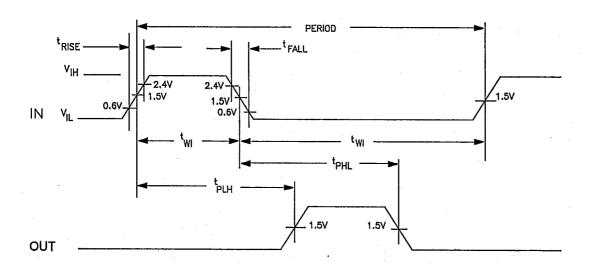
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CAPACITANCE				(t. = 25°C
PARAMETER	SYMBOL	MAX.	UNITS	NOTES
Input Capacitance	C _{IN}	10	pF	·

NOTES

- 1. All voltages are referenced to ground.
- 2. @V_{cc}=5V and 25°C. Delay accurate on both rising and falling edges within tolerances given in

TIMING DIAGRAM SILICON DELAY LINE-Figure 5



TERMINOLOGY

Period: The time elapsed between the leading edge of the first pulse and the leading edge of the following pulse.

 $\mathbf{t}_{\mathbf{WI}}$ (Pulse Width): The elapsed time on the pulse between the 1.5V point on the leading edge and the 1.5V point on the trailing edge, or the 1.5V point on the trailing edge and the 1.5V point on the leading edge.

 \mathbf{t}_{RISE} (Input Rise Time): The elapsed time between the 20% and the 80% point on the leading edge of the input pulse.

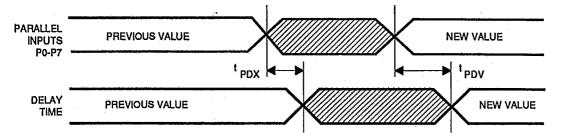
t_{FALL} (Input Fall Time): The elapsed time between the 80% and the 20% point on the trailing edge of the input pulse.

 \mathbf{t}_{PLH} (Time Delay, Rising): The elapsed time between the 1.5V point on the leading edge of the input pulse and the 1.5V point on the leading edge of the output pulse.

 t_{PHL} (Time Delay, Falling): The elapsed time between the 1.5V point on the trailing edge of the input pulse and the 1.5V point on the trailing edge of the output pulse.

T- 47-17 DS1020

TIMING DIAGRAM NON-LATCHED PARALLEL MODE (S=1, E=1) Figure 6



TIMING DIAGRAM LATCHED PARALLEL MODE (S=1) Figure 7

